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PATENT
450100-05076

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Takehiko NAKANO et al.
International Application No.: PCT/JP2004/003327
International Filing Date: March 12, 2004
For: DEVICE-TO-DEVICE AUTHENTICATION SYSTEM,
DEVICE-TO-DEVICE AUTHENTICATION METHOD,
COMMUNICATION APPARATUS, AND COMPUTER
PROGRAM

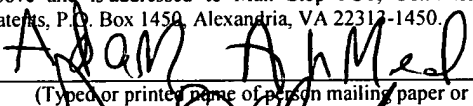
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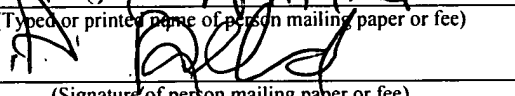
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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP2004/003327. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

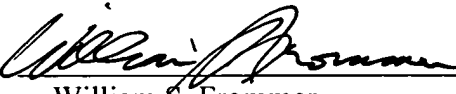
REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP
Attorneys for Applicants

By: 
William S. Frommer
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Enclosures

Based on Form PTO-1449 (3/90) LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 450100-05076	SERIAL NO. Filed Concurrently Herewith
	APPLICANT Takehiko NAKANO et al.	
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	2001/0054159	12/20/01	Hoshino			
	AB						
	AC						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	JP 2002-175224	06/21/02	Japan			
	AM	JP 2002-7233	01/11/02	Japan			
	AN	JP 2003-76805	03/14/03	Japan			
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